Retraction Note

Retraction Note to: Sol–gel derived Co₃O₄ thin films: effect of annealing on structural, morphological and optoelectronic properties

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Published online:

9 September 2021

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Retraction to:

Journal of Materials Science: Materials in Electronics (2012) 23:772–778

<https://doi.org/10.1007/s10854-011-0491-x>

The Editor-in-Chief has retracted this article due to substantial overlap with a previously published article [1] and an article which was under consideration at the same time [2]. This article is therefore redundant. M.A. Chougule, P.R. Godse, R.D. Sakhare and V.B. Patil agree with this retraction. S. G. Pawar and Shashwati Sen have not responded to correspondence from the Publisher about this retraction.

References

1. V. Patil, S. Pawar, M. Chougule, B. Raut, R. Mulik, S. Sen, New method for fabrication of Co₃O₄ thin film sensors: structural, morphological and optoelectronic properties. *Sens. Transducers* **128**(5), 100–114 (2011). https://www.sensorsportal.com/HTML/DIGEST/P_804.htm
2. P. Vikas, J. Pradeep, C. Manik, S. Shashwati, Synthesis and characterization of Co₃O₄ thin film. *Soft Nanosci. Lett.* **2**(1), 1–7 (2012). <https://doi.org/10.4236/snl.2012.21001>

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